

Notice of References Cited	Application/Control No. 10/023,167 ✓	Applicant(s)/Patent Under Reexamination OP DE BEEK ET AL.	
	Examiner John B. Strege	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,835,688	05-1989	Kimura, Tokunori	345/424
*	B	US-2001/0013867	08-2001	WATANABE et al.	345/427
*	C	US-6,603,474	08-2003	Cobb et al.	345/421
*	D	US-6,480,732	11-2002	Tanaka et al.	600/425
*	E	US-6,542,153	04-2003	Liu et al.	345/424
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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